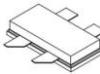
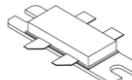




# 1785MHz-1880MHz, 180W, 28V High Power RF LDMOS FETs

## Description

The ITCH18180B4 is a 180-watt, internally matched LDMOS FET, designed for multicarrier WCDMA/PCS/DCS/LTE base station and ISM applications with frequencies from 1785 to 1880 MHz. It can be used in Class AB/B and Class C for all typical cellular base station modulation formats.

<b>ITCH18180B4</b>

<b>ITCH18180B4E</b>


- Typical Performance of Doherty Demo (On Innogration fixture with device soldered):

$V_{DD} = 28$  Volts,  $I_{DQMAIN} = 450$  mA,  $V_{GPEAK} = 0.8$  V, Pulse CW, Pulse Width=20 us, Duty cycle=10% .

Freq (MHz)	$P_{-1dB}$ (dBm)	$P_{-3dB}$ (dBm)	$\eta_D @ P_{-3}$ (%)	$P_{avg}=45$ dBm WCDMA Signal <sup>(1)</sup>		
				Gp (dB)	$\eta_D$ (%)	ACPR <sub>5M</sub> (dBc)
1785	51.0	52.6	58.7	14.6	44.2	-27.0
1795	51.3	52.7	59.8	14.7	44.2	-27.4
1805	51.1	52.6	59.8	14.8	44.4	-27.4

- Typical Performance of Doherty Demo (On Innogration fixture with device soldered):

$V_{DD} = 28$  Volts,  $I_{DQMAIN} = 600$  mA,  $V_{GPEAK} = 0.9$  V, Pulse CW, Pulse Width=20 us, Duty cycle=10% .

Freq (MHz)	$P_{-1dB}$ (dBm)	$P_{-3dB}$ (dBm)	$\eta_D @ P_{-3}$ (%)	$P_{avg}=45$ dBm WCDMA Signal <sup>(1)</sup>		
				Gp (dB)	$\eta_D$ (%)	ACPR <sub>5M</sub> (dBc)
1805	51.2	53.2	57.4	15.6	42.0	-29.8
1842.5	51.4	53.3	57.7	15.5	41.6	-31.8
1880	51.0	52.9	57.5	15.3	41.7	-32.7

Note(1) WCDMA signal: 3GPP test model 1; 1 to 64 DPCH; Channel Bandwidth=3.84MHz, PAR =10.5 dB at 0.01 % probability on CCDF.

## Features

- High Efficiency and Linear Gain Operations
- Integrated ESD Protection
- Internally Matched for Ease of Use
- Excellent thermal stability, low HCl drift
- Large Positive and Negative Gate/Source Voltage Range for Improved Class C Operation
- Pb-free, RoHS-compliant

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	70	Vdc
Gate-Source Voltage	$V_{GS}$	-10 to +10	Vdc
Operating Voltage	$V_{DD}$	+32	Vdc
Storage Temperature Range	$T_{Stg}$	-65 to +150	°C
Case Operating Temperature	$T_c$	+150	°C
Operating Junction Temperature	$T_j$	+225	°C

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value	Unit
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Thermal Resistance, Junction to Case $T_C = 85^\circ\text{C}$ , $T_J = 200^\circ\text{C}$ , DC test	R <sub>θJC</sub>	0.38	$^\circ\text{C}/\text{W}$
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**Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22--A114)	Class 2

**Table 4. Electrical Characteristics** (TA = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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**DC Characteristics (per Section)**

Drain-Source Breakdown Voltage (V <sub>GS</sub> =0V; I <sub>D</sub> =1mA)	V <sub>DSS</sub>	65	70		V
Zero Gate Voltage Drain Leakage Current (V <sub>DS</sub> = 28 V, V <sub>GS</sub> = 0 V)	I <sub>DSS</sub>			10	$\mu\text{A}$
Gate-Source Leakage Current (V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 0 V)	I <sub>GSS</sub>			1	$\mu\text{A}$
Gate Threshold Voltage (V <sub>DS</sub> = 28V, I <sub>D</sub> = 600 uA)	V <sub>GS(th)</sub>		1.8		V
Gate Quiescent Voltage (V <sub>DD</sub> = 28 V, I <sub>DQ</sub> = 800 mA, Measured in Functional Test)	V <sub>GS(Q)</sub>	2.2	2.7	3.2	V

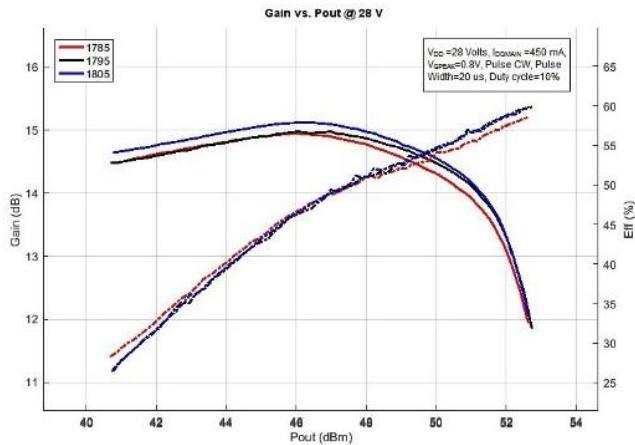
**Functional Tests (On Innogration doherty demo, 50 ohm system)** : V<sub>DD</sub> = 28 Vdc, I<sub>DQMAIN</sub> =600 mA, V<sub>GPEAK</sub>=0.9V, f = 1880 MHz, Pulse CW, Pulse Width=20 us, Duty cycle=10%.

Power Gain @ 30W Output	G <sub>p</sub>		15.3		dB
1 dB Compression Point	P <sub>-1dB</sub>		51.0		dBm
3dB Compression Point	P <sub>-3dB</sub>		52.9		dBm
Drain Efficiency@P3dB	$\eta_D$		57.5		%
Input Return Loss	IRL		-7		dB

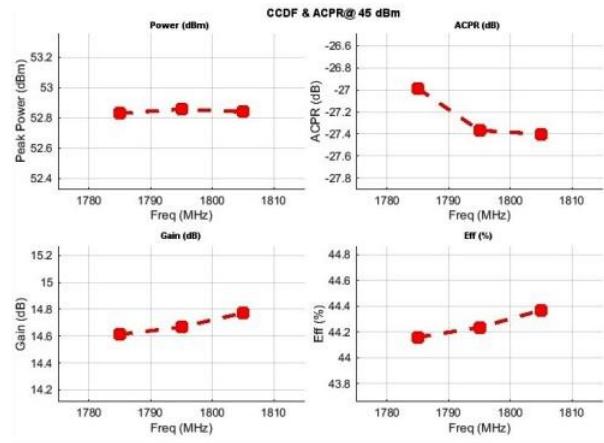
**Load Mismatch (On Innogration Test Fixture, 50 ohm system):** V<sub>DD</sub> = 28 Vdc, I<sub>DQ</sub> = 800 mA, f = 1880 MHz

VSWR 10:1 at 180W pulse CW Output Power	No Device Degradation
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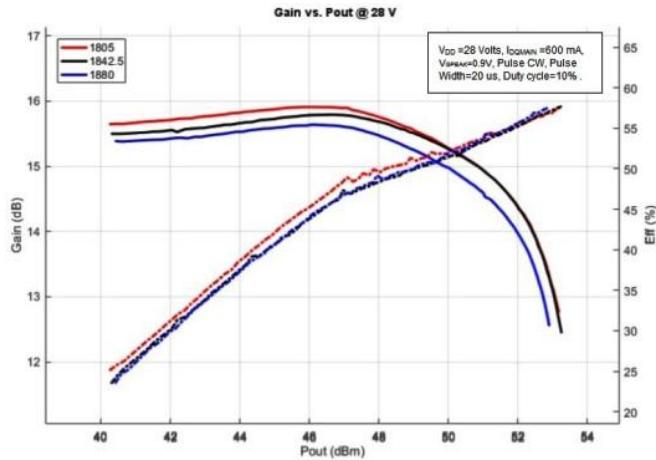
## TYPICAL CHARACTERISTICS



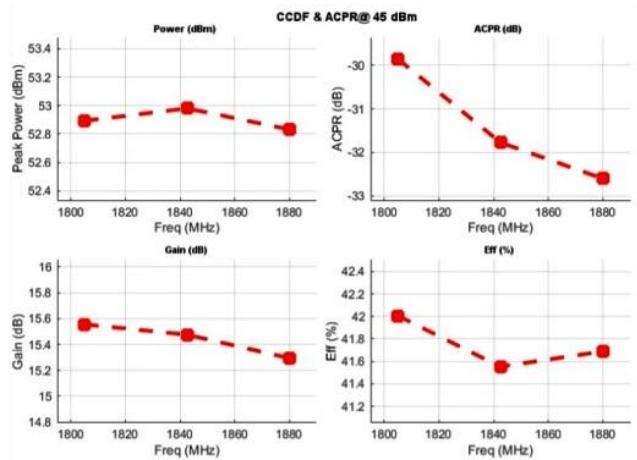
**Figure 1. Power gain and drain efficiency as function of Pulse output power(Doherty Circuit 1785-1805MHz)**



**Figure 2. Single-Carrier WCDMA CCDF and ACPR<sub>5MHz</sub> @ 30W as function frequency(Doherty Circuit 1785-1805MHz)**



**Figure 3. Power gain and drain efficiency as function of Pulse output power(Doherty Circuit 1805-1880MHz)**

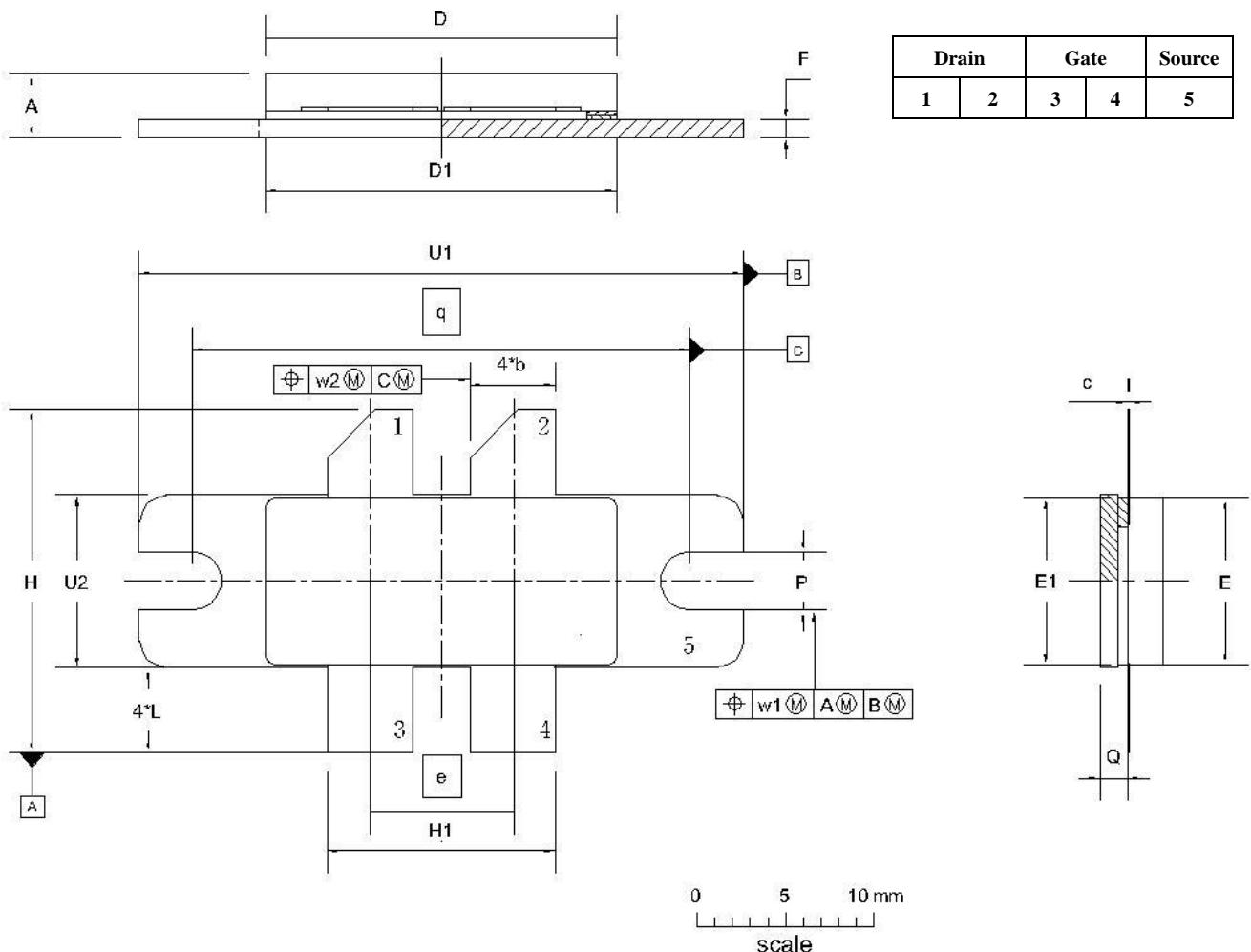


**Figure 4. Single-Carrier WCDMA CCDF and ACPR<sub>5MHz</sub> @ 30W as function frequency(Doherty Circuit 1805-1880MHz)**



## Package Outline

Eared Flanged Ceramic Package; 2 mounting holes; 4 leads

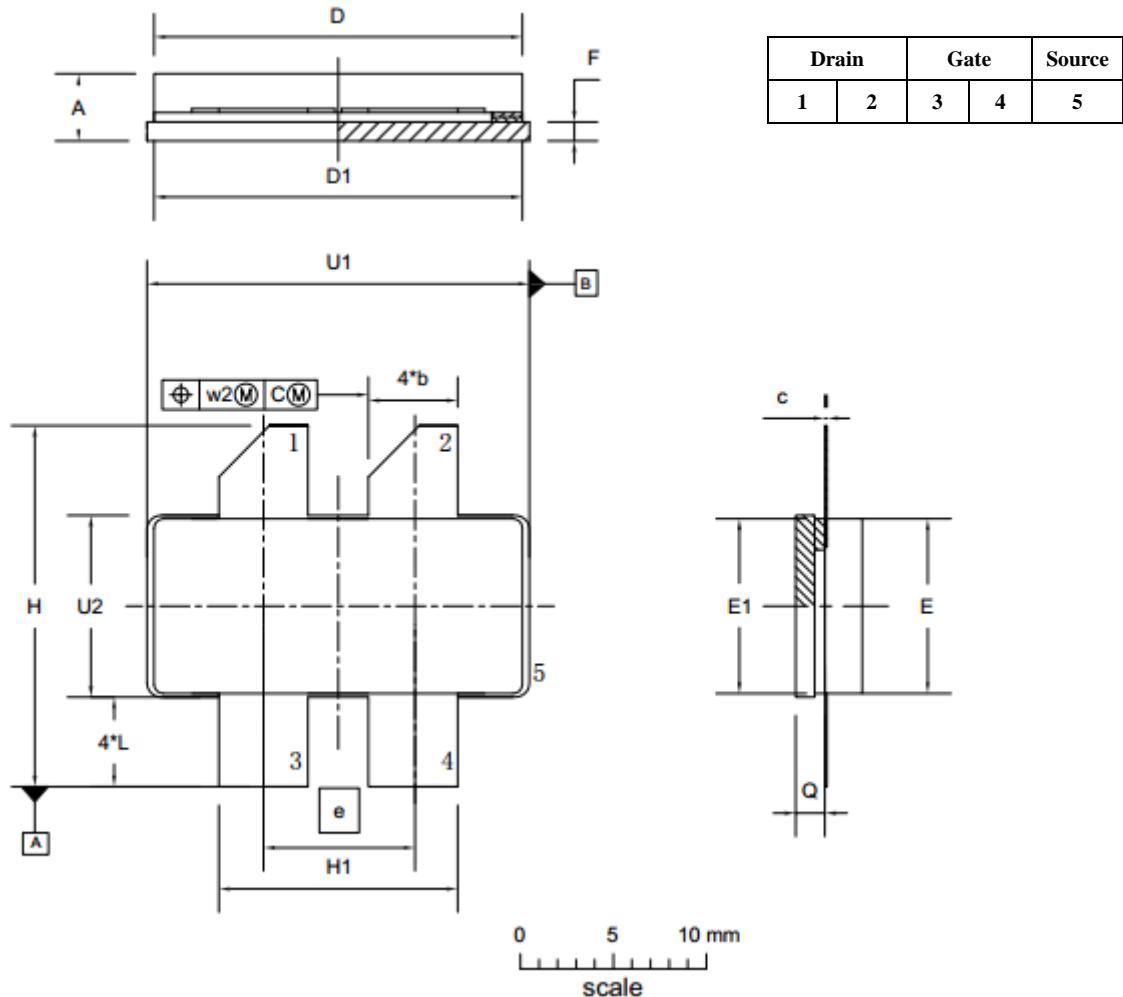


UNIT	A	b	c	D	D <sub>1</sub>	e	E	E <sub>1</sub>	F	H	H <sub>1</sub>	L	p	Q	q	U <sub>1</sub>	U <sub>2</sub>	W <sub>1</sub>	W <sub>2</sub>
mm	4.72	4.67	0.15	20.02	19.96	7.90	9.50	9.53	1.14	19.94	12.98	5.33	3.38	1.70	27.94	34.16	9.91	0.25	0.51
inches	0.186	0.194	0.006	0.788	0.786	0.311	0.374	0.375	0.045	0.785	0.511	0.210	0.133	0.067	1.100	1.345	0.390	0.01	0.02
	3.43	4.93	0.08	19.61	19.66		9.30	9.25	0.89	18.92	12.73	4.32	3.12	1.45	33.91	9.65			

OUTLINE VERSION	REFERENCE			EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA		
PKG-B4E					03/12/2013



## Earless Flanged Ceramic Package; 4 leads



UNIT	A	b	c	D	D <sub>1</sub>	e	E	E <sub>1</sub>	F	H	H1	L	Q	U <sub>1</sub>	U <sub>2</sub>	W <sub>1</sub>	W <sub>2</sub>
mm	4.72	4.67	0.15	20.02	19.96	7.90	9.50	9.53	1.14	19.94	12.98	5.33	1.70	20.70	9.91	0.25	0.51
inches	0.186	0.194	0.006	0.788	0.786	0.311	0.374	0.375	0.045	0.785	0.511	0.210	0.067	0.815	0.390	0.01	0.02
	3.43	4.93	0.08	19.61	19.66	9.30	9.25	0.89	18.92	12.73	4.32	1.45	20.45	9.65			

OUTLINE VERSION	REFERENCE			EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA		
PKG-B4					03/12/2013



## Revision history

Table 5. Document revision history

Date	Revision	Datasheet Status
2017/09/07	Rev 1.0	Preliminary Datasheet

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